TABLE I. DEVICE PARAMETERS 1/

JPL PART # ST12213-	MFG.	MFG PART #	PACKAGE STYLE	DETAIL SCREENING TESTS	ELECTRICAL CHARACTERISTICS & GROUP A TESTS	RADIATION (TID) LEVEL RAD(Si)
QN3375SR	STM	2N3375	TO-60 2/	MIL-S-19500/341	MIL-S-19500/341 (TABLE I)	100k 3/

NOTES:

1/ This drawing, in conjunction with CS515581, imposes all requirements for procurement of these devices.

2/ Device physical dimensions shall conform to MIL-S-19500/341, Figure 1.

3/ Devices supplied to this drawing shall be capable of meeting the Group D, Subgroup 2 radiation hardness assurance (RHA) requirements of MIL-S-19500 at the specified TID level.

4. This standard takes precedence over documents referenced herein.

RELEASED THRU SECTION 356 DATA MANAGEMENT: DATE:

REVISION: A APPROVED BY: DATE:

APPROVED SOURCE(S)

THE ITEM LISTED IN THE APPROVED SOURCE BLOCK AND IDENTIFIED BY VENDOR NAME, ADDRESS, AND PART NUMBER WILL BE EVALUATED AND TESTED BY THE JPL ELECTRONIC PARTS RELIABILITY SECTION OR ITS DELEGATED ALTERNATE BEFORE BEING APPROVED FOR USE. NON-JPL USERS SHALL CHECK WITH THE ELECTRONIC PARTS RELIABILITY SECTION ON THE STATUS OF THE PART'S APPROVAL BEFORE USING.

VENDOR PART NO	VENDOR	JPL PART NO

JET PROPULSION LABORATORY CALIFORNIA INSTITUTE OF TECHNOLOGY

CAGE NO 23835

Procurement specification:
CS515581
Screening specification:
ZPP-2073-GEN

Custodian: Electronic Parts Reliability Section 514

TITLE:
TRANSISTOR, SILICON NPN
POWER, HIGH FREQUENCY

DETAIL SPECIFICATION

ST 12213

SHEET 1 OF 1

FILE (Sec. 514): F:\USERS\514\SPECS\ACT-DETL\ST12213.A

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